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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/612,281	06/30/2003	Brian Taggart	884.853US1	5797

21186 7590 05/30/2006

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EXAMINER
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NORRIS, JEREMY C

ART UNIT	PAPER NUMBER
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2841

DATE MAILED: 05/30/2006

Please find below and/or attached an Office communication concerning this application or proceeding.

## Office Action Summary

Application No.

10/612,281

Applicant(s)

TAGGART ET AL.

Examiner

Jeremy C. Norris

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-- The MAILING DATE of this communication appears on the cover sheet with the correspondence address --

### Period for Reply

A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) OR THIRTY (30) DAYS, WHICHEVER IS LONGER, FROM THE MAILING DATE OF THIS COMMUNICATION.

- Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.
- If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.
- Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133). Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).

### Status

- 1) ☒ Responsive to communication(s) filed on 06 March 2006.
- 2a) ☒ This action is **FINAL**. 2b) ☐ This action is non-final.
- 3) ☐ Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under *Ex parte Quayle*, 1935 C.D. 11, 453 O.G. 213.

### Disposition of Claims

- 4) ☒ Claim(s) 1-30 is/are pending in the application.
- 4a) Of the above claim(s) \_\_\_\_\_ is/are withdrawn from consideration.
- 5) ☐ Claim(s) \_\_\_\_\_ is/are allowed.
- 6) ☒ Claim(s) 1-30 is/are rejected.
- 7) ☐ Claim(s) \_\_\_\_\_ is/are objected to.
- 8) ☐ Claim(s) \_\_\_\_\_ are subject to restriction and/or election requirement.

### Application Papers

- 9) ☐ The specification is objected to by the Examiner.
- 10) ☒ The drawing(s) filed on 02 May 2005 is/are: a) ☒ accepted or b) ☐ objected to by the Examiner.
- Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).
- Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).
- 11) ☐ The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.

### Priority under 35 U.S.C. § 119

- 12) ☐ Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).
- a) ☐ All b) ☐ Some \* c) ☐ None of:
1. ☐ Certified copies of the priority documents have been received.
2. ☐ Certified copies of the priority documents have been received in Application No. \_\_\_\_\_.
3. ☐ Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).

\* See the attached detailed Office action for a list of the certified copies not received.

### Attachment(s)

- 1) ☐ Notice of References Cited (PTO-892)
- 2) ☐ Notice of Draftsperson's Patent Drawing Review (PTO-948)
- 3) ☐ Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08)  
Paper No(s)/Mail Date \_\_\_\_\_.

- 4) ☐ Interview Summary (PTO-413)  
Paper No(s)/Mail Date. \_\_\_\_\_.
- 5) ☐ Notice of Informal Patent Application (PTO-152)
- 6) ☐ Other: \_\_\_\_\_.

## DETAILED ACTION

### *Claim Rejections - 35 USC § 103*

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negated by the manner in which the invention was made.

The factual inquiries set forth in *Graham v. John Deere Co.*, 383 U.S. 1, 148 USPQ 459 (1966), that are applied for establishing a background for determining obviousness under 35 U.S.C. 103(a) are summarized as follows:

1. Determining the scope and contents of the prior art.
2. Ascertaining the differences between the prior art and the claims at issue.
3. Resolving the level of ordinary skill in the pertinent art.
4. Considering objective evidence present in the application indicating obviousness or nonobviousness.

This application currently names joint inventors. In considering patentability of the claims under 35 U.S.C. 103(a), the examiner presumes that the subject matter of the various claims was commonly owned at the time any inventions covered therein were made absent any evidence to the contrary. Applicant is advised of the obligation under 37 CFR 1.56 to point out the inventor and invention dates of each claim that was not commonly owned at the time a later invention was made in order for the examiner to consider the applicability of 35 U.S.C. 103(c) and potential 35 U.S.C. 102(e), (f) or (g) prior art under 35 U.S.C. 103(a).

Claims 1, 2, 4, 8-12, 14-18, and 20-27 are rejected under 35 U.S.C. 103(a) as being unpatentable over US 6,084,295 (Horiuchi).

Horiuchi discloses, referring primarily to figures 4 & 5, an article comprising: a wire-bonding mounting substrate (5) including a lower protective layer (shown not specifically referenced); a first wire-bond pad (22); and a first via (18) in the wire-bonding mounting substrate, wherein the first via is in electrical contact with the first wire-bond pad, and wherein the first via is disposed symmetrically and directly below the first wire-bond pad. Horiuchi does not specifically disclose an upper protective layer where the first and second wire bond pads and the upper protective layer are disposed upon each other [claim 1]. However, it is well known to dispose layers so as to protect circuit wiring as evidenced by Horiuchi (see 26, figure 2, col. 3, line 65 – col. 4, line 5). Therefore, it would have been obvious to one having ordinary skill in the art at the time of invention to form an upper protective layer in the invention of Horiuchi. The motivation for doing so would have been to protect the wiring from impurities such as dust. Also, the modified invention of Horiuchi teaches further including: an interconnect (38) filling the via [claim 4],

Additionally, Horiuchi discloses, referring primarily to figures 4 and 5, an article comprising: a wire-bonding mounting substrate (5) including a lower protective layer (shown not specifically referenced); a first wire-bond pad (22); and a first via (36) in the wire-bonding mounting substrate, wherein the first via is in electrical contact with the first wire-bond pad, and wherein the first via is disposed directly below the first wire-bond pad, wherein the wire-bonding mounting substrate includes a first edge, the article further including: a second wire-bond pad (22); a second via (36) in the wire-bonding mounting substrate, wherein the second via is in electrical contact with the second wire-

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bond pad, and wherein the second via is disposed directly below the second wire-bond pad; and wherein the first via and the second via are staggered with respect to the first edge of the wire-bonding mounting substrate (figure 4). Horiuchi does not specifically disclose an upper protective layer where the first and second wire bond pads and the upper protective layer are disposed upon each other [claim 2]. However, it is well known to dispose layers so as to protect circuit wiring as evidenced by Horiuchi (see 26, figure 2, col. 3, line 65 – col. 4, line 5). Therefore, it would have been obvious to one having ordinary skill in the art at the time of invention to form an upper protective layer in the invention of Horiuchi. The motivation for doing so would have been to protect the wiring from impurities such as dust.

Similarly, Horiuchi discloses, referring primarily to figures 4-5, a package comprising: a wire-bonding mounting substrate (5) including a lower protective layer (shown not specifically referenced); a first wire-bond pad (22); a first via (36) in the wire-bonding mounting substrate, wherein the first via is in electrical contact with the first wire-bond pad, and wherein the first via is disposed symmetrically and directly below the first wire-bond pad; a die (10); and a first wire bond (20) that couples the die to the first wire-bond pad. Horiuchi does not specifically disclose an upper protective layer where the first and second wire bond pads and the upper protective layer are disposed upon each other [claim 8]. However, it is well known to dispose layers so as to protect circuit wiring as evidenced by Horiuchi (see 26, figure 2, col. 3, line 65 – col. 4, line 5). Therefore, it would have been obvious to one having ordinary skill in the art at the time of invention to form an upper protective layer in the invention of Horiuchi. The

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motivation for doing so would have been to protect the wiring from impurities such as dust. Moreover, the modified invention of Horiuchi teaches further including: a second wire-bond pad (22) disposed upon the first surface; a second via (36) in the wire-bonding mounting substrate, wherein the second via is in electrical contact with the second wire-bond pad, and wherein the second via is disposed directly below the second wire-bond pad [claim 9], further including: a second wire-bond pad (22) disposed upon the first surface; a second via (36) in the wire-bonding mounting substrate, wherein the second via is in electrical contact with the second wire-bond pad, and wherein the second via is disposed directly below the second wire-bond pad; a second bond wire (20) that couples the die to the second wire-bond pad; and wherein the respective lengths of the first bond wire and the second bond wire are adjusted so as to tune the package (col. 5, lines 50-60) [claim 10], further including: a first bump (12) coupled to the first via [claim 11], further including: a first bump (12) coupled to the first via; and a first trace (24) that makes an electrical contact to the first bump [claim 12], wherein the first wire-bond pad is part of a plurality of wire-bond pads, and wherein each wire-bond pad is directly above a corresponding via from a plurality of vias (figure 5) [claim 14], wherein the first wire-bond pad is part of a plurality of wire-bond pads, wherein each wire-bond pad is directly above a corresponding via from a plurality of vias, and wherein each via is coupled to a bump (figure 5) [claim 15], wherein the first wire-bond pad is part of a plurality of wire-bond pads, wherein each wire-bond pad is directly above a corresponding via from a plurality of vias, wherein each via is coupled

to a bump, and wherein each bump is directly below a corresponding via (figure 5) [claim 16].

Also, Horiuchi discloses, referring primarily to figures 4-5, a process comprising: forming a first via (36) in a wire-bonding mounting substrate (5), wherein the wire-bonding mounting substrate includes a first surface and a lower protective layer (shown not specifically referenced), and wherein forming proceeds from the second surface toward the first surface; and patterning a first wire-bond pad (22) symmetrically and directly over the first via. Horiuchi does not specifically disclose an upper protective layer where the first and second wire bond pads and the upper protective layer are disposed upon each other [claim 17]. However, it is well known to dispose layers so as to protect circuit wiring as evidenced by Horiuchi (see 26, figure 2, col. 3, line 65 – col. 4, line 5). Therefore, it would have been obvious to one having ordinary skill in the art at the time of invention to form an upper protective layer in the invention of Horiuchi. The motivation for doing so would have been to protect the wiring from impurities such as dust. Additionally, the modified invention of Horiuchi teaches wherein forming ceases upon contact with the first wire-bond pad [claim 18], further including: filling the first via with an interconnect (18) [claim 20], wherein forming the first via precedes patterning the first wire-bond pad (col. 6, lines 1-10) [claim 21], further including: filling the first via with an interconnect (18); coupling the first via to a first bump (12) [claim 22], further including: coupling the first wire-bond pad to a first bump (12) [claim 23].

Furthermore, Horiuchi discloses, referring primarily to figures 4-5, a method comprising: forming a first via (36) in a wire-bonding mounting substrate (5), wherein the

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wire-bonding mounting substrate includes a lower protective layer (shown not specifically referenced), and wherein forming proceeds from the second surface toward the first surface; patterning a first wire-bond pad (22) directly over the first via; and coupling a die (10) to the first wire-bond pad. Horiuchi does not specifically disclose an upper protective layer where the first and second wire bond pads and the upper protective layer are disposed upon each other [claim 24]. However, it is well known to dispose layers so as to protect circuit wiring as evidenced by Horiuchi (see 26, figure 2, col. 3, line 65 – col. 4, line 5). Therefore, it would have been obvious to one having ordinary skill in the art at the time of invention to form an upper protective layer in the invention of Horiuchi. The motivation for doing so would have been to protect the wiring from impurities such as dust. Furthermore, the modified invention of Horiuchi teaches further including: forming a second via (36) in the wire-bonding mounting substrate; patterning a second wire-bond pad (22) directly over the second via; and coupling the die to the second wire-bond pad [claim 25], further including: filling the first via with an interconnect (18) [claim 26], further including: filling the first via with an interconnect (18); and coupling the first via to a first bump (12) [claim 27].

Claims 3, 5-7, and 9 are rejected under 35 U.S.C. 103(a) as being unpatentable over Horiuchi as applied to claims 1 and 17 above, and further in view of US 6,252,178 B1 (Hashemi).

Regarding claims 3, 5, and 19, the modified invention of Horiuchi teaches the claimed invention as described above except the modified invention of Horiuchi does



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not specifically teach wherein the via includes a liner [claims 3, 19], further including; an interconnect filling the via [claim 5]. However, Hashemi teaches a via including a liner (col. 3, lines 60-66), further including; an interconnect (260) filling the via. Therefore, it would have been obvious to one having ordinary skill in the art at the time of invention to include a liner in the via of the modified invention of Horiuchi. The motivation for doing so would have been to increase the adhesion of the conductive paste to the board and thus make a more reliable electrical connection.

Regarding claims 6 & 7, the modified invention of Horiuchi teaches the claimed invention as described above except the modified invention of Horiuchi does not specifically teach wherein the wire-bond pad includes a first layer and a second layer, wherein at least one of the first layer and the second layer is selected from a precious metal, a precious metal alloy, silver, gold, platinum, nickel, palladium, platinum, cobalt, rhodium, iridium, and combinations thereof [claim 6], wherein the wire-bond pad includes a first layer and a second layer, and wherein the second layer is one of identical material to the first layer, or at least one of a more noble, or a softer metal than the first layer [claim 7]. However, Hashemi teaches a wire-bond pad including a first layer and a second layer, wherein at least one of the first layer and the second layer is selected from a precious metal, a precious metal alloy, silver, gold, platinum, nickel, palladium, platinum, cobalt, rhodium, iridium, and combinations thereof, wherein the wire-bond pad includes a first layer and a second layer, and wherein the second layer is one of identical material to the first layer, or at least one of a more noble, or a softer metal than the first layer. Therefore, it would have been obvious to one having ordinary

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skill in the art at the time of invention to add a second layer of gold over the first layer of the wire bond pad in the modified invention of Horiuchi as taught by Hashemi. The motivation for doing so would have been to improve adhesion between the wire bond pad and the wire bond wire.

Claim 13 is rejected under 35 U.S.C. 103(a) as being unpatentable over Horiuchi as applied to claim 8 above, and further in view of US 5,936,844 (Walton).

Regarding claim 13, the modified invention of Horiuchi discloses the claimed invention as described above with respect to claim 8 including a first bump (12) coupled to the first via. Horiuchi does not specifically disclose a larger substrate coupled to the first bump [claim 13]. However, it is well known in the art to attach a BGA semiconductor device to a larger substrate via a bump as evidenced by Walton (figure 11B). Therefore, it would have been obvious to one having ordinary skill in the art at the time of invention to attach the semiconductor device of modified Horiuchi to a larger substrate via the first bump as is known in the art and evidenced by Walton. The motivation for doing so would have been to transmit signals from the die to the larger substrate.

Claims 28-30 are rejected under 35 U.S.C. 103(a) as being unpatentable over Walton in view of Horiuchi.

Walton discloses, referring primarily to figures 11A-B, 28. a computing system comprising: a semiconductor device (232) having a die and dynamic random-access

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memory (162) coupled to the die. Walton does not specifically disclose that the semiconductor device comprises a wire-bonding mounting substrate including a first surface and a second surface; a first wire-bond pad disposed upon the first surface; a first via in the wire-bonding mounting substrate, wherein the first via is in electrical contact with the first wire-bond pad, and wherein the first via is disposed symmetrically and directly below the first wire-bond pad; a die disposed on the first surface. Horiuchi discloses, a semiconductor device comprising: a wire-bonding mounting substrate (5) including a lower protective layer; a first wire-bond pad (22) disposed upon the first surface; a first via (18) in the wire-bonding mounting substrate, wherein the first via is in electrical contact with the first wire-bond pad, and wherein the first via is disposed symmetrically and directly below the first wire-bond pad; and a die (10). Therefore, it would have been obvious to one having ordinary skill in the art at the time of invention to use the semiconductor device taught by Horiuchi as the semiconductor device in the invention of Walton. The motivation for doing so would have been to use a semiconductor device with improved electrical characteristics (Horiuchi – col. 5, lines 50-60). Furthermore, the modified invention of Walton does not specifically teach and upper protective layer [claim 28]. However, it is well known to dispose layers so as to protect circuit wiring as evidenced by Horiuchi (see 26, figure 2, col. 3, line 65 – col. 4, line 5). Therefore, it would have been obvious to one having ordinary skill in the art at the time of invention to form an upper protective layer in the modified invention of Walton. The motivation for doing so would have been to protect the wiring from impurities such as dust.

Moreover, the modified invention of Walton teaches, wherein the computing system is disposed in one of a computer, a wireless communicator, a hand-held device, an automobile, a locomotive, an aircraft, a watercraft, and a spacecraft (Walton – col. 4, lines 50-55) [claim 29], wherein the die is selected from a data storage device, a digital signal processor, a micro controller, an application specific integrated circuit, and a microprocessor (Walton – col. 5, lines 30-40) [claim 30].

### ***Response to Arguments***

Applicant's arguments with respect to claims 1-30 have been considered but are moot in view of the new ground(s) of rejection.

### ***Conclusion***

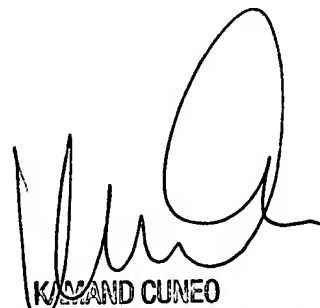
Any inquiry concerning this communication or earlier communications from the examiner should be directed to Jeremy C. Norris whose telephone number is 571-272-1932. The examiner can normally be reached on Monday - Friday, 9:30 am - 5:30 pm.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Kamand Cuneo can be reached on 571-272-1957. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

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